United States Patent [19]

Arnoux

[11] Patent Number: Des. 307,244

[45] Date of Patent: ** Apr. 17, 1990

[54]	CURREN	PROBE
[76]	Inventor:	Daniel Arnoux, 10 Rue d'Alsace, St. Germain en Lave, France, 78100
[**]	Term:	14 Years
[21]	Appl. No.:	3,922
[22] [52] [58]		Jan. 16, 1987
[56] References Cited		
U.S. PATENT DOCUMENTS		
D. D.	288,301 2/ 300,307 3/	977 McKenzie et al

Primary Examiner—Nelson C. Holtje
Assistant Examiner—Antoine D. Davis
Attorney, Agent, or Firm—Wolf, Greenfield & Sacks

[57] CLAIM

The ornamental design for a current probe, as shown and described.

DESCRIPTION

FIG. 1 is a top, front, and right side perspective view of a current probe showing my new design, with the cord member being eliminated for ease of illustration;

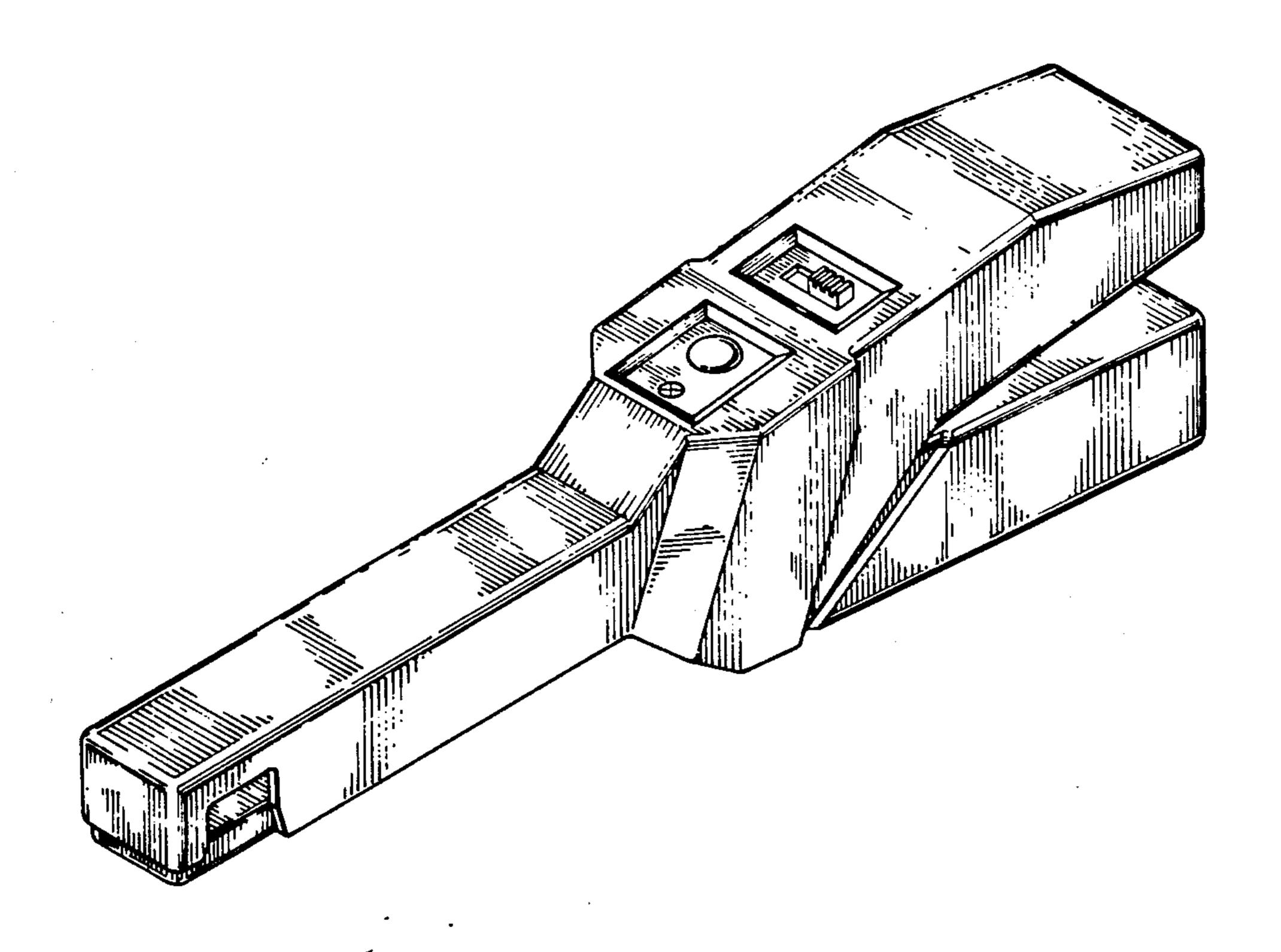
FIG. 2 is a top plan view of the device.

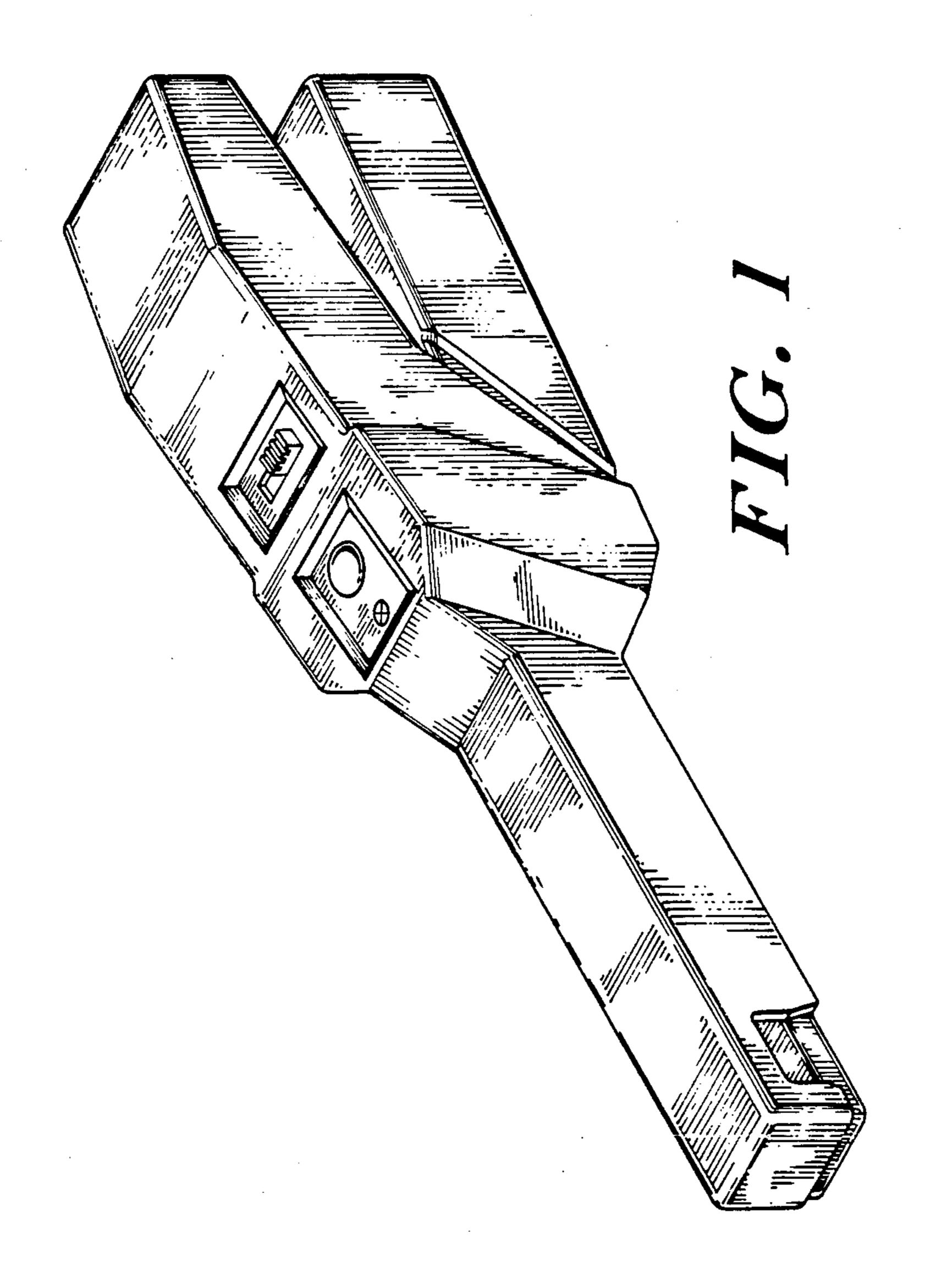
FIG. 3 is an elevational view of the device, as seen from the right side of FIG. 1, the device having been rotated 180° about its longest axis. The view of the other side of the device is a mirror image.

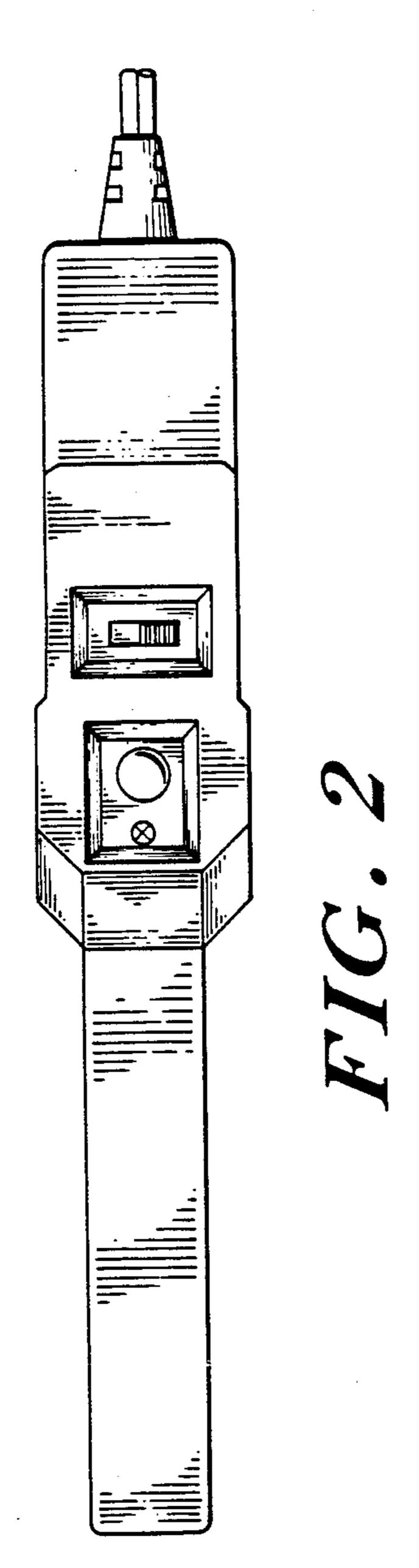
FIG. 4 is a bottom plan view;

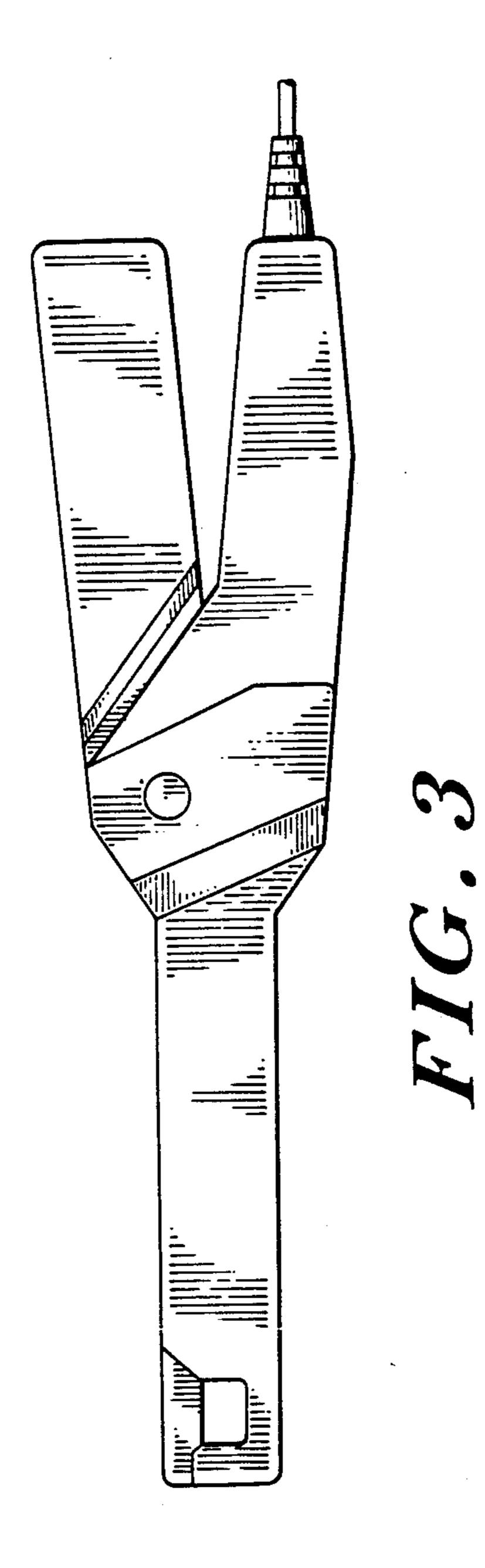
FIG. 5 is a front elevational view; and

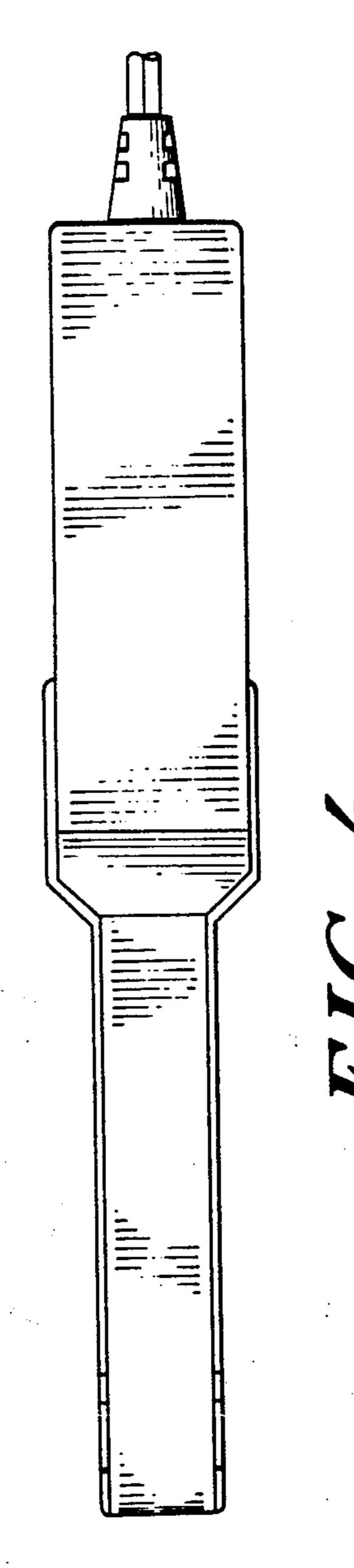
FIG. 6 is a rear elevational view thereof.

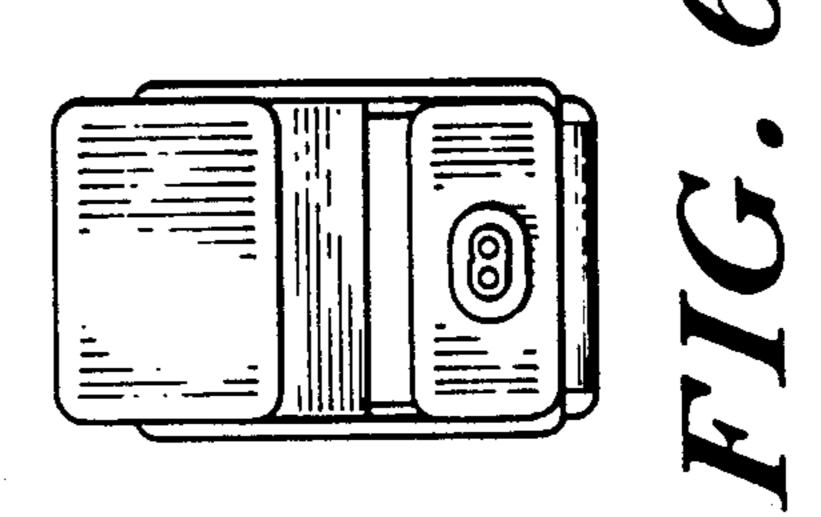


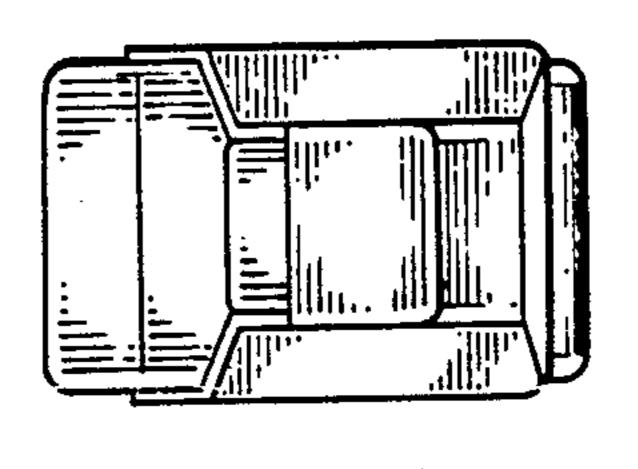












E. DI